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## AUTOMOTIVE CURRENT TRANSDUCER HC2F100-SN CLIPS



## Introduction

## Principle of HC2F CLIPS Family

The HC2F CLIPS Family is for the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with galvanic isolation between the primary circuit (high power) and the secondary circuit (electronic circuit).

The HC2F CLIPS family gives you the choice of having different current measuring ranges in the same housing.

## Features

- Open Loop transducer using the Hall effect
- Low voltage application
- Unipolar + 5 V DC power supply
- Primary current measuring range from 80 A up to 250 A
- Maximum RMS primary admissible current: defined by busbar to have $\mathrm{T}^{\circ}<+150^{\circ} \mathrm{C}$
- Operating temperature range: $-40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<+125^{\circ} \mathrm{C}$
- Output voltage: full ratiometric (in sensitivity and offset)
- Compact design for PCB mounting.


## Advantages

- Excellent accuracy
- Very good linearity
- Very low thermal offset drift
- Very low thermal sensitivity drift
- Wide frequency bandwidth
- No insertion losses.


## Automotive applications

- Electrical Power Steering
- Starter Generators
- Converters ...

The open loop transducers uses a Hall effect integrated circuit. The magnetic flux density $B$, contributing to the rise of the Hall voltage, is generated by the primary current $\mathrm{I}_{\mathrm{p}}$ to be measured. The current to be measured $I_{p}$ is supplied by a current source i.e. battery or generator (Fig. 1).

Within the linear region of the hysteresis cycle, B is proportional to:

$$
\text { B }\left(\mathbf{I}_{\mathrm{P}}\right)=\text { constant }(\mathrm{a}) \times \mathbf{I}_{P}
$$

The Hall voltage is thus expressed by:

$$
\mathbf{V}_{H}=\left(R_{H} / d\right) \times I \times \text { constant }(a) \times I_{P}
$$

Except for $\mathbf{I}_{\mathrm{p}}$, all terms of this equation are constant. Therefore:

$$
\mathbf{V}_{\mathrm{H}}=\text { constant }(\mathrm{b}) \times \mathrm{I}_{\mathrm{P}}
$$

The measurement signal $\mathbf{V}_{\mathrm{H}}$ amplified to supply the user output voltage or current.


Fig. 1: Principle of the open loop transducer

## HC2F100-SN CLIPS

Dimensions HC2F100-SN CLIPS family (in mm)


## Bill of materials

- Plastic case
- Magnetic core
- Pins and primary bus bar
- Mass

PBT GF 30
FeNi alloy
Copper alloy tin
plated (lead free)
6 g

## Electronic schematic



## Remarks

- General tolerance

$$
\pm 0.2 \mathrm{~mm}
$$

- $\mathbf{V}_{\text {OUT }}>\frac{\mathbf{V}_{\mathbf{C}}}{2}$ when $\mathbf{I}_{\mathrm{P}}$ flows in the direction of the arrow.

Power supply decoupling capacitor: C2 $=47 \mathrm{nF}$
EMC protection capacitor $\quad \mathrm{C} 3=4.7 \mathrm{nF}$
Optional:
High frequency signal noise filter:
$R 1>100 \Omega$
C1 = defined according to the system frequency bandwidth

## HC2F100-SN CLIPS

## Absolute maximum ratings (not operating)

| Parameter | Symbol | Unit | Specification | Conditions |
| :---: | :---: | :---: | :---: | :---: |
| Maximun peak primary current (not operating) | $I_{\text {P max }}$ | A | Defined by busbar to have $\mathrm{T}^{\circ} \leq 150^{\circ} \mathrm{C}$ |  |
| Primary nominal DC or current rms | $\mathrm{I}_{\text {PN }}$ | A | Defined by busbar to have $\mathrm{T}^{\circ} \leq 150^{\circ} \mathrm{C}$ |  |
| Maximun supply voltage (not operating) | $\mathbf{V}_{\mathrm{Cmax}}$ | V | 7 |  |
| Secondary maximum admissible power | $\mathrm{P}_{\mathrm{S}_{\text {max }}}$ | mW | 150 |  |
| Ambient operating temperature | $\mathrm{T}_{\mathrm{A}}$ | ${ }^{\circ} \mathrm{C}$ | $-40<\mathrm{T}_{\mathrm{A}}<125^{\circ} \mathrm{C}$ |  |
| Ambient storage temperature | $\mathrm{T}_{\text {S }}$ | ${ }^{\circ} \mathrm{C}$ | $-40<\mathrm{T}_{\text {s }}<125^{\circ} \mathrm{C}$ |  |
| Electrostatic discharge voltage | $\mathrm{V}_{\text {ESD }}$ | V | 2000 |  |
| Maximum admissible vibration | $\gamma$ | m. $\mathrm{s}^{-2}$ | 100 | see page $5 / 5$ |
| Rms voltage for AC insulation test $50 \mathrm{~Hz}, 1 \mathrm{~min}$ | $\mathrm{V}_{\mathrm{d}}$ | V | 1500 | see page 5/5 |
| Creepage distance | dCp | mm | 1.67 |  |
| Clearance | dCI | mm | 1.80 | CTI $=425$ |

## Operating characteristics

| Parameter | Symbol | Unit | Specification |  |  | Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typical | Max |  |
| Electrical Data |  |  |  |  |  |  |
| Primary current, measuring range | $\mathrm{I}_{\text {PM }}$ | A | -100 |  | 100 | @ - $40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<125^{\circ} \mathrm{C}$ |
| Supply voltage ${ }^{1)}$ | $\mathrm{V}_{\mathrm{c}}$ | V | 4.75 | 5.00 | 5.25 | @ - $40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<125^{\circ} \mathrm{C}$ |
| Output voltage (Analog) | $\mathrm{V}_{\text {OUT }}$ | V | $\mathbf{V}_{\text {OUT }}=\left(\mathbf{V}_{\mathrm{C}} / 5\right) \times\left(2.5+0.02 \times \mathbf{I}_{\mathrm{P}}\right)$ |  |  | @ $-40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<125^{\circ} \mathrm{C}$ |
| Sensitivity | G | V/A | 0.0196 | 0.02 | 0.0204 | @ $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C} ; \mathrm{V}_{\mathrm{C}}=5 \mathrm{~V}$ |
| Offset voltage | $\mathrm{v}_{0}$ | V | 2.481 | 2.5 | 2.519 | @ $\mathrm{V}_{\mathrm{C}}=5 \mathrm{~V} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C} ; \mathrm{I}_{\mathrm{P}}=0 \mathrm{~A}$ |
| Current consumption | $\mathrm{I}_{\mathrm{c}}$ | mA | - | 15 | 20 | @ - $40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<125^{\circ} \mathrm{C} ; 4.75 \mathrm{~V}<\mathrm{V}_{\mathrm{C}}<5.25 \mathrm{~V}$ |
| Load resistance | $\mathrm{R}_{\mathrm{L}}$ | $\mathrm{K} \Omega$ | 2 | - | - |  |
| Output internal resistance | $\mathrm{R}_{\text {OUT }}$ | $\Omega$ | - | - | 10 |  |
| Performance Data ${ }^{(1)}$ |  |  |  |  |  |  |
| Sensitivity error | $\varepsilon_{\text {G }}$ | \% | -2.0 | $\pm 0.7$ | 2.0 | $@ \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{C}}=5 \mathrm{~V}$; Gth $=0.02 \mathrm{~V} / \mathrm{A}$ |
| Electrical offset | $\mathrm{I}_{\mathrm{OE}}$ | A | -0.7 | $\pm 0.25$ | 0.7 | @ $\mathrm{V}_{\mathrm{C}}=5.00 \mathrm{~V} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |
|  | $\mathrm{V}_{\mathrm{OE}}$ | mV | -14 | $\pm 5$ | 14 |  |
| Magnetic offset | $\mathrm{I}_{\text {om }}$ | A | -0.25 | $\pm 0.15$ | 0.25 | @ After excursion to $\pm I_{P} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |
|  | $\mathrm{V}_{\text {ом }}$ | mV | -5 | $\pm 3$ | 5 |  |
|  |  |  |  |  |  | @ $-40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<125^{\circ} \mathrm{C} ; \mathrm{V}_{\mathrm{c}}=5.00 \mathrm{~V}$ |
|  |  |  |  |  |  |  |  |  |
| $\mathbf{V}_{\text {OE }}$ | $\mathrm{TCV}_{\text {oeav }}$ | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ | -0.14 | $\pm 0.08$ | 0.14 |  |
| Average temperature coefficient of $\mathbf{G}$ | TCG ${ }_{\text {AV }}$ | \%/ ${ }^{\circ} \mathrm{C}$ | -0.04 | $\pm 0.02$ | 0.04 | @ $-40^{\circ} \mathrm{C}<\mathrm{T}^{\circ}<125^{\circ} \mathrm{C} ; \mathrm{V}_{\mathrm{C}}=5.00 \mathrm{~V}$ |
| Linearity error | $\varepsilon_{\mathrm{L}}$ | \% $\mathrm{I}_{\mathrm{p}}$ | -1.0 | $\pm 0.2$ | 1.0 | @ $\mathrm{I}_{\mathrm{P}} ; \mathrm{V}_{\mathrm{C}}=5.00 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |
| Response time | $\mathrm{t}_{\mathrm{r}}$ | $\mu \mathrm{s}$ | - | 15 | 20 | @ di/dt $=50 \mathrm{~A} / \mu \mathrm{s} ; \mathrm{I}_{\mathrm{T}}=60 \mathrm{~A}$ |
| Frequency bandwidth ${ }^{2)}$ | BW | kHz | 20 | - | - | @ -3 dB; $\mathrm{I}_{\mathrm{T}}=20 \mathrm{Arms}$ |
| Output voltage noise peak-peak | $\mathrm{V}_{\text {no p-p }}$ | mV | - | 35 | 43 | @ $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C} ; 0 \mathrm{~Hz}<\mathrm{f}<1 \mathrm{MHz}$ |
| Output voltage noise rms | $\mathrm{V}_{\text {norms }}$ | mV | - | - | 4 | @ $T_{A}=25^{\circ} \mathrm{C} ; 0 \mathrm{~Hz}<\mathrm{f}<1 \mathrm{MHz}$ |



Notes: ${ }^{1)}$ The output voltage $\mathbf{V}_{\text {out }}$ is fully ratiometric. The offset and sensitivity are dependent on the supply voltage $\mathbf{V}_{\mathrm{C}}$ relative to the following formula:
$I_{\mathrm{P}}=\left(\mathrm{V}_{\text {out }}-\frac{\mathrm{V}_{\mathrm{c}}}{2}\right) \times \frac{1}{\mathrm{G}} \times \frac{5}{\mathrm{~V}_{\mathrm{c}}} \quad$ with G in $(\mathrm{V} / \mathrm{A})$
${ }^{2)}$ Small signal only to avoid excessive heating of the busbar, the magnetic core and the ASIC.

HC2F100-SN CLIPS


Fig. 3: Typical linearity versus primary current at $\mathrm{T}^{\circ}=25^{\circ} \mathrm{C}$


Fig. 5: Typical sensitivity error versus temperature

## Influence of the external magnetic field

Test conditions:

- transducer sample : HC2F100-SN CLIPS
- diameter of the disturbing conductor : 6 mm
- dimension of the primary bus-bar : $6 \times 2 \times 200 \mathrm{~mm}$
- tested at ambient temperature



Fig. 4: Typical output voltage versus primary current across temperature


Fig. 6: Typical offset error versus temperature

## Current levels:

|  | CASE 1 | CASE 2 | CASE 3 | CASE 4 |
| :--- | :---: | :---: | :---: | :---: |
| I disturbant | +100 A | -100 A | +100 A | -100 A |
| I primary | 0 A | 0 A | +100 A | +100 A |



## HC2F100-SN CLIPS

## PERFORMANCES PARAMETERS DEFINITIONS

## Output noise voltage:

The output voltage noise is the result of the noise floor of the Hall elements and the linear $\mathrm{I}_{\mathrm{C}}$ amplifier gain.

## Magnetic offset:

The magnetic offset is the consequence of an over-current on the primary side. It's defined after an excursion of $\mathrm{I}_{\mathrm{P} \text { max }}$.

## Linearity:

The maximum positive or negative discrepancy with a reference straight line $V_{\text {out }}=f\left(I_{p}\right)$.
Unit: linearity (\%) expressed with full scale of $\mathrm{I}_{\mathrm{P} \text { max }}$.


## Response time (delay time) $\mathrm{t}_{\mathrm{r}}$ :

The time between the primary current signal and the output signal reach at $90 \%$ of its final value


## Typical:

Theorical value or usual accuracy recorded during the production.

## Sensitivity:

The Transducer's sensitivity $\mathbf{G}$ is the slope of the straight line $V_{\text {out }}=f\left(I_{p}\right)$, it must establish the relation:
$\mathrm{V}_{\text {out }}\left(\mathrm{I}_{\mathrm{P}}\right)=\mathrm{V}_{\mathrm{C}} / 5\left(\mathrm{G} \times \mathrm{I}_{\mathrm{P}}+2.5\right)\left(^{*}\right)$
(*) For all symetrics transducers.

## Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at $25^{\circ} \mathrm{C}$.
The offset variation $I_{\text {OT }}$ is a maximum variation the offset in the temperature range:
$\mathrm{I}_{\mathrm{OT}}=\mathrm{I}_{\mathrm{OE}} \max -\mathrm{I}_{\mathrm{OE}} \min$
The Offset drift TCI OEAV is the $\mathrm{I}_{\mathrm{OT}}$ value divided by the temperature range.

## Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at $25^{\circ} \mathrm{C}$.
The sensitivity variation $\mathbf{G}_{\boldsymbol{T}}$ is the maximum variation (in ppm or $\%$ ) of the sensitivity in the temperature range:
$\mathbf{G}_{\mathrm{T}}=\left(\right.$ Sensitivity max-Sensitivity min) / Sensitivity at $25^{\circ} \mathrm{C}$.
The sensitivity drift $\mathbf{T C G}_{A V}$ is the $\mathbf{G}_{\boldsymbol{T}}$ value divided by the temperature range.

Offset voltage @ $I_{p}=0 \mathrm{~A}$ :
Is the output voltage when the primary current is null. The ideal value of $\mathbf{V}_{\mathrm{o}}$ is $\mathbf{V}_{\mathrm{c}} / 2$ at $\mathbf{V}_{\mathrm{C}}=5 \mathrm{~V}$. So, the difference of $\mathbf{V}_{\mathrm{o}}-\mathbf{V}_{\mathrm{C}} / 2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis.
Environmental test specifications

| Name | Standard | Conditions |
| :---: | :---: | :---: |
| Low $\mathrm{T}^{\circ}$ storage | IEC 60068 Part 2-1 | $\mathrm{T}^{\circ}-40^{\circ} \mathrm{C} / 100 \mathrm{H}$ <br> not connected |
| Thermal shocks | IEC 60068 Part 2-14 | $\mathrm{T}^{\circ}-30^{\circ} \mathrm{C}$ to $110^{\circ} \mathrm{C} / 1000$ cycles not connected |
| Low $\mathrm{T}^{\circ}$ operation at min supply voltage | IEC 60068 Part 2-1 | $\begin{aligned} & \mathrm{T}^{\circ}-40^{\circ} \mathrm{C} / 1000 \mathrm{H} \\ & \text { supply voltage }=4.75 \mathrm{~V} \end{aligned}$ |
| Hight $\mathrm{T}^{\circ}$ operation at max supply voltage | IEC 60068 Part 2-2 | $\begin{aligned} & \mathrm{T}^{\circ} 125^{\circ} \mathrm{C} / 1000 \mathrm{H} \\ & \text { supply voltage }=5.25 \mathrm{~V} \end{aligned}$ |
| Temperature humidity bias | IEC 60068 Part 2-3 | $\begin{aligned} & \mathrm{T}^{\circ} 90^{\circ} \mathrm{C} / 95 \% \mathrm{RH} / 1000 \mathrm{H} \\ & \text { supply voltage }=5.25 \mathrm{~V} \end{aligned}$ |
| Pressure cooker |  | ```T 125}\mp@subsup{}{}{\circ}\textrm{C}/100% RH, P 0.178 Mpa/100  supply voltage = 5 V``` |
| Mechanical Tests |  |  |
| Vibration | IEC 60068-2-64 | Room $\mathrm{T}^{\circ}$, acceleration $100 \mathrm{~m} / \mathrm{s} 2$, frequency 20 to $500 \mathrm{~Hz} / 96 \mathrm{H}$ each axis |
| Drop test | IEC 60068 Part 2-29 | Heigh 750 mm concret floor each directions |
| EMC Test |  |  |
| Electrostatic discharge | JESD22-A114-B | Applied voltage $= \pm 2 \mathrm{kV}$ pin to pin number of discharge $=1$ |

